SCOPE: MICROPROCESSOR SUPERVISORY CIRCUIT

Device Type	Generic Number
01	MAX691AMJE/883B
02	MAX693AMJE/883B

<u>Case Outline(s).</u> The case outlines shall be designated in Mil-Std-1835 and as follows:

Outline Letter	Mil-Std-1835	Case Outline	Package Code
JE	GDIP1-T16 or CDIP2-T16	16 LEAD CERD	IP J16

Absolute Maximum Ratings

Ausolute iviaalinum Katings
Terminal Voltages (with respect to GND)
V _{CC} 0.3V to +6V
VBATT0.3V to +6V
All other Inputs0.3V to $(V_{OUT} + 0.3V)$
Input Current
V _{CC} Peak
V _{CC} Continuous
VBATT Peak
VBATT Continuous
GND, BATT ON
All other Outputs
Continuous Power Dissipation
Lead Temperature (soldering, 10 seconds)+300°C
Storage Temperature65°C to +150°C
16 lead CERDIP(derate 10.00mW/°C above +70°C)
Junction Temperature T_J
Thermal Resistance, Junction to Case, OJC:
Case Outline 16 lead CERDIP
Thermal Resistance, Junction to Ambient, OJA:
Case Outline 16 lead CERDIP
Recommended Operating Conditions.
Ambient Operating Range (T _A)55°C to 125°C

Stresses above the absolute maximum rating may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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TABLE 1 ELECTRICAL TESTS

		CONDITIONS					
TEST	Symbol	-55 C $<=T_A<=+125$ °C VBATT= $+2.8$ V V _{CC} = 4.75 V to 5.5V for -01, V _{CC} = 4.5 V to 5.5V for -02, Unless otherwise specified	Group A Subgroup	Device type	Limits Min	Limits Max	Unit
Operating Voltage Range V _{CC} , VBATT		Note 1	1,2,3	All	0	5.5	V
Output Voltage	V_{OUT}	V_{CC} =4.5V I_{OUT} =250mA I_{OUT} =25mA	1,2,3	All		V _{CC} 40 V _{CC} 05	V
V _{CC} - to -V _{OUT} ON Resistance		V _{CC} =4.5V	1,2,3	All		1.6	Ohm
V _{OUT} in Battery-Backup Mode		VBATT=4.5V, I _{OUT} =20mA VBATT=2.8V, I _{OUT} =10mA VBATT=2.0V, I _{OUT} =5mA	1,2,3	All	VBATT- 0.3 VBATT- .25 VBATT- .15		V
VBATT-to-V _{OUT} ON Resistance		VBATT=4.5V VBATT=2.8V VBATT=2.0V	1,2,3	All	.13	15 25 30	Ohm
Supply Current in Normal Operating Mode (Excludes I_{OUT})		V _{CC} >VBATT-1V	1,2,3	All		100	μΑ
Supply Current in Battery-Backup Mode (Excludes I_{OUT})		V _{CC} <vbatt -1.2v,<br="">VBATT =2.8V NOTE 2</vbatt>	1 2,3	All		1 5	μΑ
VBATT Standby Current		VBATT +0.2V<=V _{CC} NOTE 3	1 2,3	All	-0.1 -1.0	0.02 0.02	μΑ
BATT ON Output Low Voltage		I _{SINK} =3.2mA	1,2,3	All		0.4	V
BATT ON Output Short- Circuit Current RESET AND WATCHDOG		Source Current	1,2,3	All	1.0	100	μΑ
TIMER				0.1			
Reset Threshold Voltage			1,2,3	01 02	4.50 4.25	4.75 4.50	V
Reset Active Timeout Period, Internal Oscillator		Power up	9,10,11	All	140	280	ms
Watchdog Timeout Period Internal Oscillator		Long Period Short Period	9,10,11	All	1.0 70	2.25 140	sec ms
Minimum Watchdog Input Pulse Width		V_{IL} =0.8V, V_{IH} =0.75 x V_{CC}	9,10,11	All	100		ns
RESET Output Voltage		$\begin{split} &I_{SINK}{=}50\mu\text{A},V_{CC}{=}1\text{V},\\ &V\text{BATT}{=}0\text{V},\!V_{CC}\text{Falling}\\ &I_{SINK}{=}3.2\text{mA},\!V_{CC}{=}4.25\text{V}\\ &I_{SOURCE}{=}1.6\text{mA},V_{CC}{=}5\text{V} \end{split}$	1,2,3	All	3.5	0.3 0.4	V
RESET Output Short- Circuit Current		Output Source Current	1,2,3	All		20	mA
RESET Output Voltage Low		I _{SINK} =3.2mA NOTE 4	1,2,3	All		0.4	V

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TABLE 1 ELECTRICAL TESTS

TEST	Symbol	CONDITIONS	Group A Subgroup	Device type	Limits	Limits	Units
		$-55 \text{ C} <= T_A <= +125 ^{\circ}\text{C}$ $VBATT =+2.8V$ $V_{CC} =4.75V \text{ to } 5.5V \text{ for } -01,$ $V_{CC} =4.5V \text{ to } 5.5V \text{ for } -02,$ $Unless \text{ otherwise specified}$	Subgroup	type	Min	Max	
Low Line Output Voltage		I_{SINK} =3.2mA, V_{CC} =4.25V I_{SOURCE} =1 μ A, V_{CC} =5V	1,2,3	All	3.5	0.4	V
Low Line Output Short-Circuit Current		Output Source Current	1,2,3	All	+1.0	100	μΑ
WDO Output Voltage		I_{SINK} =3.2mA I_{SOURCE} =500 μ A, V_{CC} =5V	1,2,3	All	3.5	0.4	V
WDO Output Short- Circuit Current		Output Source current	1,2,3	All		10	mA
WDI Threshold Voltage		V _{IH} NOTE 5 V _{IL}	1,2,3	All	$.75 \mathrm{xV}_{\mathrm{CC}}$	0.8	V
WDI Input Current		WDI=0V WDI=V _{OUT}	1,2,3	All	-50	50	μΑ
POWER-FAIL COMPARATOR							
PFI Input Threshold		V _{CC} =5V	1,2,3	All	1.2	1.3	V
PFI Leakage Current			1,2,3	All		±25	nA
PFO Output Voltage		I_{SINK} =3.2mA I_{SOURCE} =1 μ A, V_{CC} =5V	1,2,3	All	3.5	0.4	V
PFO Output Short-circuit Current		Output Source Current	1,2,3	All	1.0	100	μΑ
CHIP-ENABLING GATING							
CE IN Leakage Current		Disable Mode	1,2,3	All		±1.0	μΑ
CE IN to CE OUT Resistance		Enable Mode NOTE 6	1,2,3	All		150	Ohm
CE OUT Short-Circuit Current (Reset Active)		Disable Mode, CE OUT=0V	1,2,3	All	0.1	2.0	mA
CE IN to CE OUT Propagation Delay		50 Ohm source impedance driver, CLOAD=50pF NOTE 7	9,10,11	All		10	ns
CE OUT Output Voltage High (Reset Active)		V _{CC} =5V, I _{OUT} =-100μA V _{CC} =0V,VBATT=2.8V, I _{OUT} =1μA	1,2,3	All	3.5 2.7		V

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TABLE 1 ELECTRICAL TESTS

TEST	Symbol	CONDITIONS $-55 \text{ C} <= T_A <= +125 ^{\circ} \text{C}$	Group A Subgroup	Device type	Limits	Limits	Units
		VBATT=+2.8V V _{CC} =4.75V to 5.5V for -01, V _{CC} =4.5V to 5.5V for -02, Unless otherwise specified			Min	Max	
INTERNAL OSCILLATOR		Siness other wise specified					
OSC IN Leakage Current		OSC SEL=0V	1,2,3	All		± 5.0	μΑ
OSC IN Input Pullup Current		OSC SEL=V _{OUT} or floating, OSC IN=0V	1,2,3	All		100	μΑ
OSC SEL Input Pullup Current		OSC IN=0V	1,2,3	All		100	μΑ

- NOTE 1: Either V_{CC} or VBATT can go to 0V, if the other is greater than 2.0V.
- NOTE 2: The supply current drawn by the device from the battery excluding I_{OUT} typically goes to 10µA when (VBATT -1V)<V_{CC}<VBATT. In most applications, this is a brief period as V_{CC} falls through this region. NOTE 3: "+" = battery-discharging current. "-" = battery-charging current.
- NOTE 4: RESET is an open-drain output and sinks current only.
- NOTE 5: WDI is internally connected to a voltage divider between V_{OUT} and GND. If unconnected, WDI is driven to 1.6V typical, disabling the watchdog function.
- NOTE 6: The chip-enable resistance is tested with V_{CC} =4.75V for MAX691A and V_{CC} =4.5V for MAX693A

$$\overline{V_{CE} \text{ IN}} = \overline{V_{CE} \text{ OUT}} = V_{CC}/2$$

NOTE 7: The chip-enable propagation delay is measured from the 50% point at CE IN to the 50% point at CE

	MAX691A	MAX693A
Nominal Reset Threshold	4.65V	4.4V
Minimum Reset Pulse Width	140/adj.	140/adj.
Nominal Watchdog Timeout Period	1.6/adj.	1.6/adj
Backup-Battery Switch	X	X
CE Write Protect	X	X
Power-Fail Comparator	X	X
Watchdog Output	X	X
Low-Line Output	X	X
Active High Reset	X	X
BATT On Output	X	X

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Figure 1. Terminal Connections

	ure 1. Terminal Connections	
CASE	J16	
OUTLINES		
TERMINAL	TERMINAL FUNCTION	TERMINAL
NUMBER		SYMBOL
1	Battery-backup Input. Connect to external battery or capacitor and charging circuit. If backup battery is not used, connect to GND.	VBATT
2	Output Supply Voltage. When V_{CC} is greater than VBATT and above the reset threshold, V_{OUT} connects to	V_{OUT}
_	V_{CC} . When V_{CC} falls below VBATT and is below the reset threshold, V_{OUT} connects to VBATT. Connect a	. 001
	$0.1\mu F$ capacitor from V_{OUT} to GND. Connect V_{OUT} to V_{CC} if no backup battery is used.	
3	Input Supply Voltage, 5V input.	V_{CC}
4	Ground. 0V reference for all signals.	GND
5	Battery ON Output. When V _{OUT} switches to VBATT, BATT ON goes high. When VOUT switches to VCC,	BATT ON
J	BATT ON goes low. Connect the base of a PNP through a current-limiting resistor to BATT ON for V _{OUT} current requirements greater than 250mA.	
6		
	LOW LINE output goes low when V_{CC} falls below the reset threshold. It returns high as soon as V_{CC} rises above the reset threshold.	LOW LINE
7	External Oscillator Input. When OSC SEL is unconnected or driven high, a 10µA pull-up connects from	OSC IN
	V _{OUT} to OSC IN, the internal oscillator sets the reset and watchdog timeout periods, and OSC IN selects	
	between fast and slow watchdog timeout periods. When OSC SEL is driven low, the reset and watchdog	
	timeout periods may be set either by a capacitor from OSC IN to ground or by an external clock at OSC IN.	
8	Oscillator Select. When OSC SEL is unconnected or driven high, the internal oscillator sets the reset delay	OSC SEL
	and watchdog timeout period. When OSC SEL is low, the external oscillator input (OSC IN) is enabled.	
	OSC SEL has a 10µA internal pull-up.	
9	Power-Fail Input. This is the noninverting input to the power-fail comparator. When PFI is	PFI
	less than 1.25V, PFO goes low. When PFI is not used, connect PFI to GND or V _{OUT} .	
10		
	Power-Fail Output. This is the output of the power-fail comparator. PFO goes low when PFI is less than	PFO
	1.25V. This is an uncommitted comparator, and has no effect on any other internal circuitry.	
11	Watchdog Input. WDI is a three-level input. If WDI remains either high or low for longer than the	WDI
	WDO was in the world with the world	
	watchdog time-out period, WDO goes low and reset is asserted for the reset timeout period. WDO remains	
	low until the next transition at WDI. Leaving WDI unconnected disables the watchdog function. WDI connects to an internal voltage divider between V_{OUT} and GND, which sets it to mid-supply when left	
	unconnected.	
12	unconnected.	
12	Chip-Enable Output. \overline{CE} OUT goes low only when \overline{CE} IN is low and V_{CC} is above the reset threshold. If	CE OUT
	CE IN is low when reset is asserted, CE OUT will stay low for 15µs or until CE IN goes high, whichever	
	occurs first.	
13	OCCUIS HISt.	
13	Chip-Enable Input. The input to chip-enable gating circuit. If CE IN is not used, connect CE IN to GND or	CE IN
		CEIN
14	V _{OUT} . Watchdog Output. If WDI remains high or low longer than the watchdog timeout	
14	watchdog Output. If with temanis high of low longer than the watchdog timeout	WDO
	period, WDO goes low and reset is asserted for the reset timeout period. WDO returns high on the next	WDO
	period, WDO goes low and reset is asserted for the reset timeout period. WDO retains high on the next	
	transition at WDI. WDO remains high if WDI is unconnected.	
15		
	RESET Output goes low whenever V _{CC} falls below the reset threshold. RESET will remain low typically for	RESET
	200ms after V _{CC} crosses the reset threshold on power up.	
16		RESET
	RESET is an active-high output. It is open drain, and the inverse of RESET.	

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QUALITY ASSURANCE

Sampling and inspection procedures shall be in accordance with MIL-Prf-38535, Appendix A as specified in Mil-Std-883.

Screening shall be in accordance with Method 5004 of Mil-Std-883. Burn-in test Method 1015:

- 1. Test Condition, A, B, C, or D.
- 2. TA = +125C minimum.
- 3. Interim and final electrical test requirements shall be specified in Table 2.

Quality conformance inspection shall be in accordance with Method 5005 of Mil-Std-883, including Groups A, B, C, and D inspection.

Group A inspection:

- 1. Tests as specified in Table 2.
- 2. Selected subgroups in Table 1, Method 5005 of Mil-Std-883 shall be omitted.

Group C and D inspections:

- a. End-point electrical parameters shall be specified in Table 1.
- b. Steady-state life test, Method 1005 of Mil-Std-883:
 - 1. Test condition A, B, C, D.
 - 2. TA = +125C, minimum
 - 3. Test duration, 1000 hours, except as permitted by Method 1005 of Mil-Std-883.

TABLE 2. ELECTRICAL TEST REQUIREMENTS

Mil-Std-883 Test Requirements	Subgroups per Method 5005, Table 1
Interim Electric Parameters Method 5004	1
Final Electrical Parameters Method 5005	1*, 2, 3, 9, 10, 11
Group A Test Requirements Method 5005	1, 2, 3, 9, 10, 11
Group C and D End-Point Electrical Parameters Method 5005	1

^{*} PDA applies to Subgroup 1 only.

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